

# Closed Loop Digital LDO Linear Controller

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Technical Report No. UCB/EECS-2019-137

<http://www2.eecs.berkeley.edu/Pubs/TechRpts/2019/EECS-2019-137.html>

October 2, 2019

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9/27/2019

# Agenda

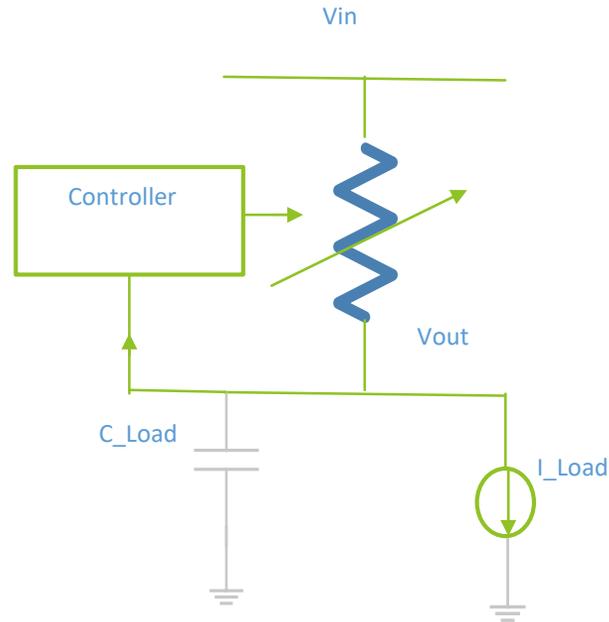
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- Discussion
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# Problem Statement

Want to build a closed loop digital LDO linear controller that provides constant  $V_{out}$  regardless of variable  $V_{in}$  with

1. At least 75% current efficiency when  $I_{Load}=0.35mA$
2. 100mV regulation range
3. High clock frequency
4. Stable/Constant  $V_{out}$

# Basic LDO

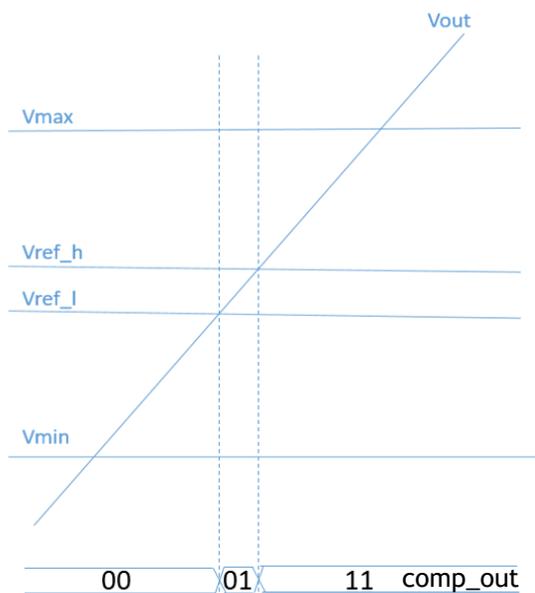


- Low dropout regulators (LDOs) are effective ways to regulate an output voltage that is powered from a higher input voltage
- A basic LDO involves a variable resistor (can be implemented by using PMOS transistors),  $I_{Load}$ ,  $C_{Load}$ , and a controller.
- The job of the controller is to keep the output voltage constant even with variable input voltage. If the load current ( $I_{Load}$ ) increases, the variable resistor should decrease to increase the current flow from the input through the resistor to the output and vice versa in order to make  $V_{out}$  remain constant.
- The controller detects the deviation of the  $V_{out}$  from its desired value and responds accordingly to either increase or decrease the variable resistor's value to keep the  $V_{out}$  constant.

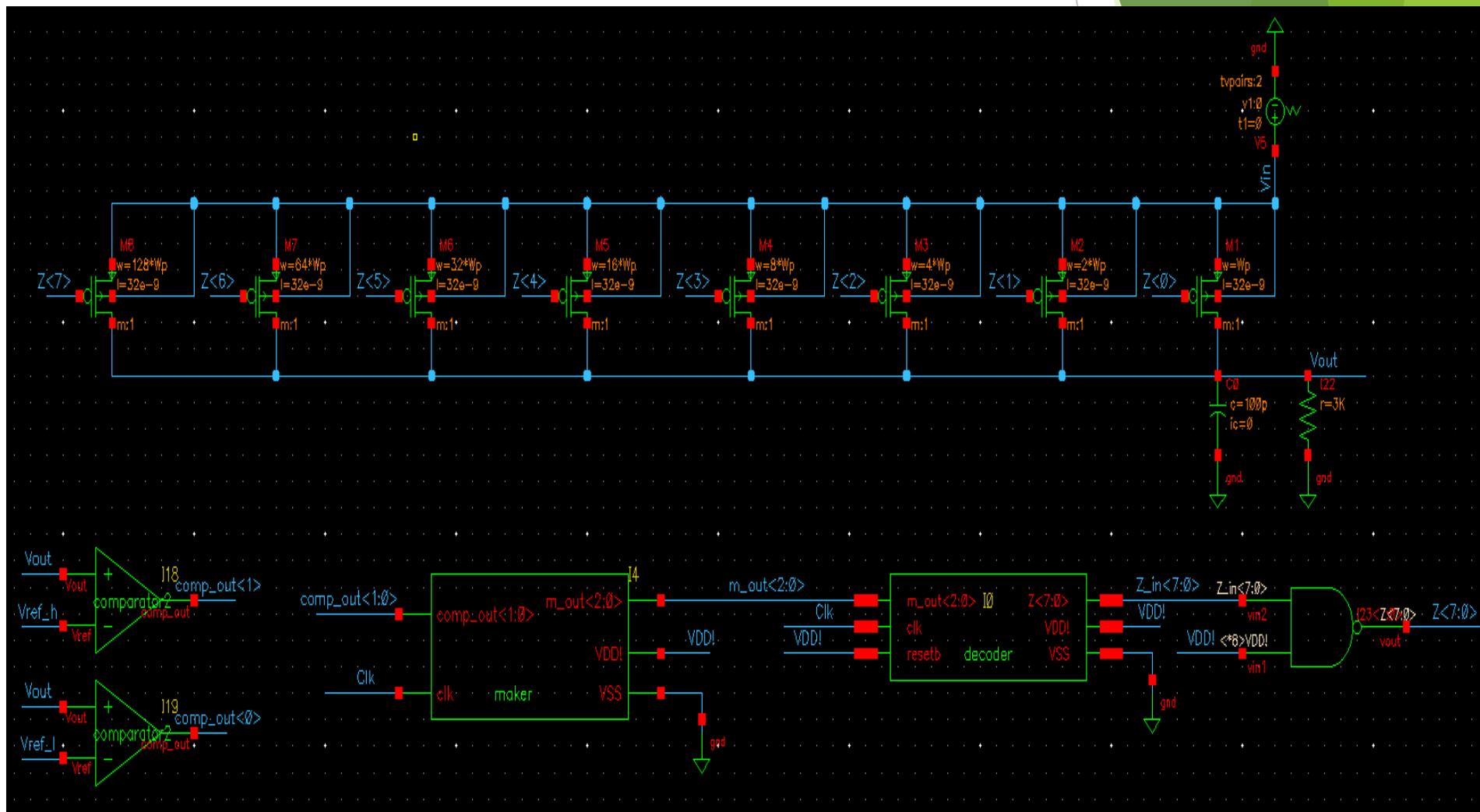
# Architecture

Closed loop design of digital LDO with digital controller (Decision maker and Decision executer), 2 Comparators and Pmos devices (binary coding power gates which has 8 different size), CL, IL:

Input of Comparators:



comp_out	m_out	Z
00=0	Up=100=4	Count up
11=3	Down=010=2	Count down
01=1	Hold=001=1	Steady state
10=2	Hold=001=1	Steady state



comp\_out (output of comparators)

m\_out (output of decision maker)

Z (output of decision executer)

# Continued...

- The job of two comparators is to detect the position of Vout and feed the information into the decision maker block.
- The decision maker block takes that information and decides if Vout should go up, down, or stay hold within Vref\_h and Vref\_l.
- The decision maker feeds this information into the 8 bit binary counter or decision executer which physically changes the value of power gate code <7:0> (input of the Pmos devices) and thus Vout.
- An example: when Comp\_h=0 (Vref\_h > Vout, or Vout is lower) and Comp\_l=0 (Vref\_l > Vout, or Vout is lower) → Decision maker output=Up → Decision executer output = Power gate code<7:0> +1. Thus, Power gate code counts up from its previous value by turning on more Pmos devices.

## Combined truth table of digital controller of LDO:

comp_out (output of comparators)	m_out (output of decision maker)	Z (output of decision executer)
00=0	Up=100=4	Count up: Power gate code<7:0> +1
11=3	Down=010=2	Count down: Power gate code<7:0> -1
01=1	Hold=001=1	Steady state
10=2	Hold=001=1	Steady state

# Continued....

- Pmos device unit size:  $W=210\text{nm}$ ,  $L=32\text{nm}$
- $V_{in}=1.05\text{V}$
- $C_{\text{Load}}=200\text{pF}$
  
- **Proposed Metrics:**
  1. Current efficiency= 75-99% for 0.35mA current load ( $R_L=3\text{K}\Omega$ )
  2. Regulation range= 100mV
  3. Clk frequency=1MHz - 1GHz
  4. Vout being stable within regulation range

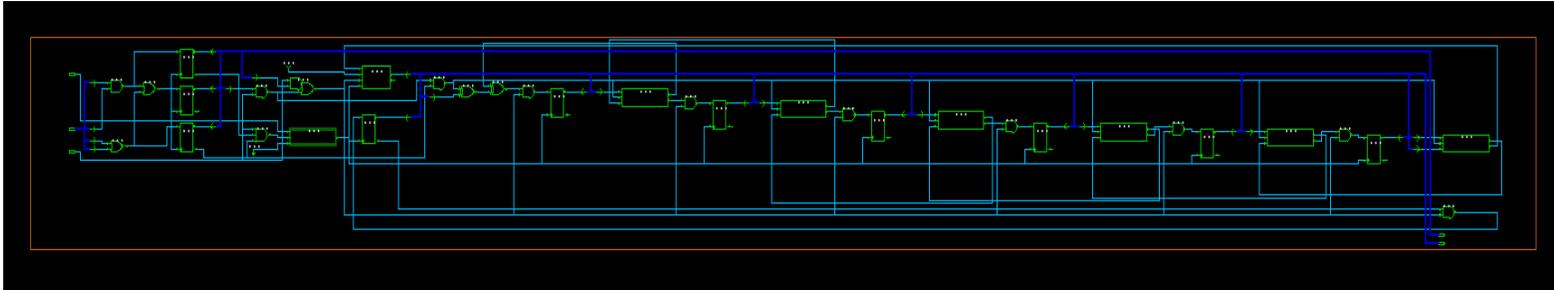
# Testbench and RTL code

```
1 `timescale 1 ns / 1 ps
2 `define expect(nodeName, nodeVal, expVal, cycle) if (nodeVal != expVal) begin \
3   $display("\t ASSERTION ON %s FAILED @ CYCLE = %d, 0x%h != EXPECTED 0x%h", \
4     nodeName,cycle,nodeVal,expVal); $stop; end
5
6 module decoder_tb();
7   reg [1:0] comp_out = 0;
8   wire [2:0] m_out;
9   wire [7:0] Z;
10  reg clk = 0;
11  wire resetb;
12  integer cycle = 0;
13  integer i;
14  wire up, down, hold;
15  assign up = m_out == 3'b100;
16  assign down = m_out == 3'b010;
17  assign hold = m_out == 3'b001;
18
19  always #(`CLOCK_PERIOD * 0.5) clk = ~clk;
20  always @(posedge clk) cycle = cycle + 1;
21  decoder decoder_inst (.comp_out(comp_out), .m_out(m_out), .Z(Z), .clk(clk), .resetb(resetb));
22
23  reg [6:0] counter ;
24  initial begin
25    counter = 7'd0;
26  end
27
28  always @(posedge clk)
29  begin
30    counter <= counter + 1 ;
31  end
32
33  assign resetb = (counter == 7'd0) ? 0 : 1;
34
35  initial begin
36    $vcdpluson;
37    // Extra cycles to flush out any initial X's
38    repeat(4) @(posedge counter[2]);
39    for (i=1; i<=50; i=i+1) begin
40      // Input + output events on clock rising edge
41      @(posedge counter[2]);
42      #0.001;
43      comp_out = i;
44    end
45    $vcdplusoff;
46    $display("\t **Ran through all test vectors**"); $finish;
47  end
48
49  initial begin
50    $monitor($time,": comp_out=%d, m_out=%b, Z=%b, cycle=%d", comp_out, m_out, Z, cycle);
51  end
52 endmodule
```

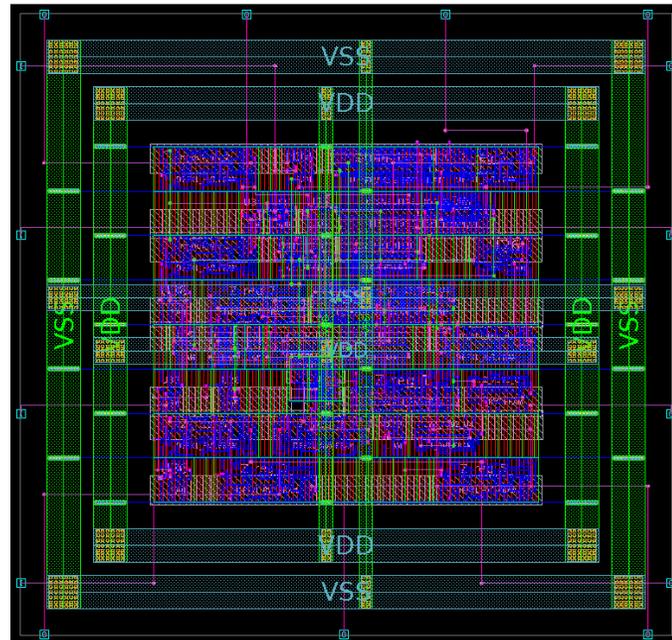
```
1 module decoder(
2   input [1:0] comp_out, //comp_out
3   input clk,
4   input resetb,
5   output reg [2:0] m_out, //decision maker output (up down hold)
6   output reg [7:0] Z); //decision executer output or power gate code
7
8 //decision maker
9 always @(posedge clk)
10 begin
11     if (comp_out == 2'b00) m_out=3'b100; //output=up
12     else if (comp_out == 2'b11) m_out=3'b010; //output=down
13     else m_out=3'b001; //when comp_out==2'b01 or 2'b10 output=hold
14 end
15
16 //decision executer
17 always @(posedge clk)
18 begin
19     if (!resetb) Z<=0;
20     else if (m_out[2]) Z<=Z+1; //count up
21     else if (m_out[1]) Z<=Z-1; // count down
22     else Z<=Z; //steady state
23 end
24
25 endmodule
```

# Results

Gate Level Schematic of LDO controller (using IC compiler):

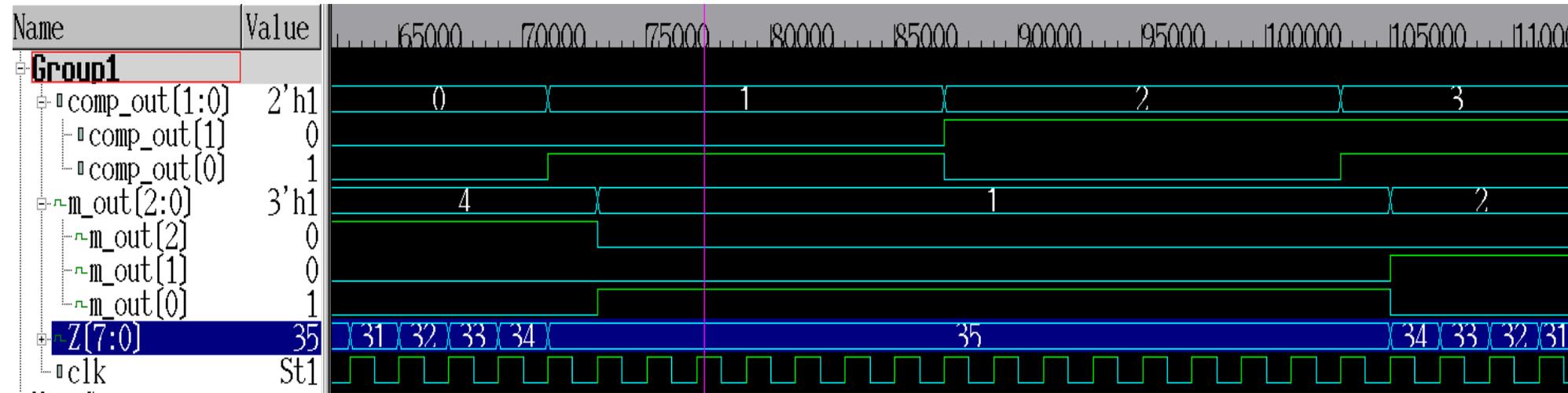


Layout of LDO controller (using IC compiler):



# Continued....

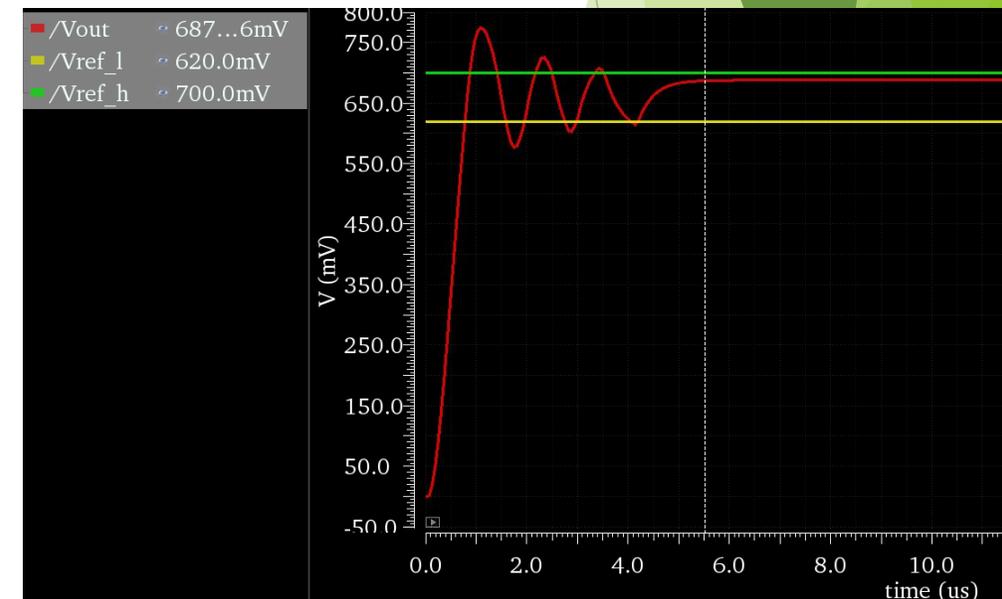
## Output Waveform (using DVE) of Digital LDO Controller:



In figure above, when  $V_{out}$  is between  $V_{ref\_l}$  &  $V_{ref\_h}$ ,  $comp\_out=01=1$ ,  $m\_out$  is Hold or  $001=1$ , and  $Z$  is at steady state= $35$  which means the controller works and when used in the closed loop LDO, the  $V_{out}$  looks like the graph on the right where  $V_{out}$  is constant/stable between  $V_{ref\_h}$  and  $V_{ref\_l}$ .

comp_out	m_out	Z
00=0	Up=100=4	Count up
11=3	Down=010=2	Count down
01=1	Hold=001=1	Steady state
10=2	Hold=001=1	Steady state

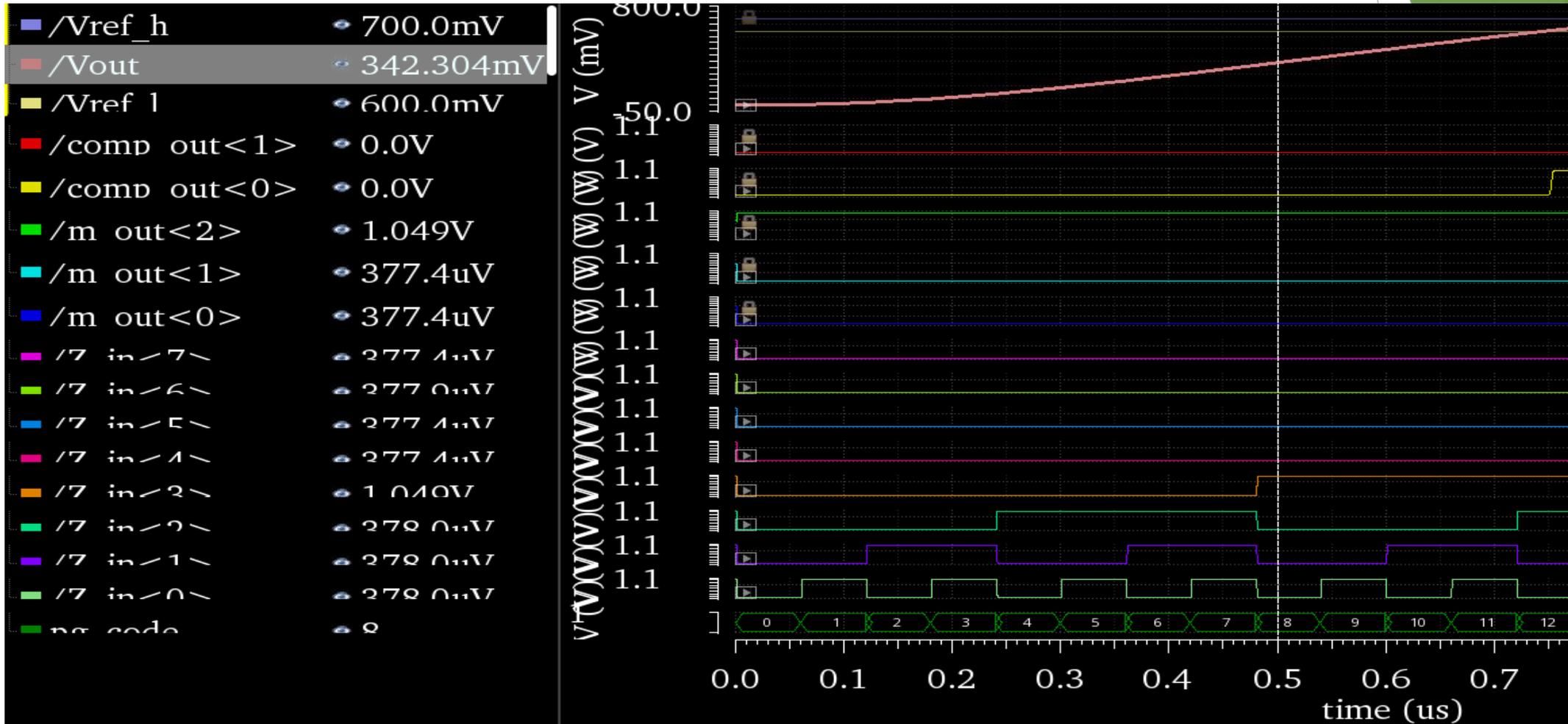
**Vout waveform:** The transient of the number of turned-on switches



# Details of Closed Loop LDO

00=0	Up=100=4	Count up
11=3	Down=010=2	Count down
01=1	Hold=001=1	Steady state
10=2	Hold=001=1	Steady state

1. Comparator, decision maker, decision executer output waveform when Vout is increasing at 0.5us:

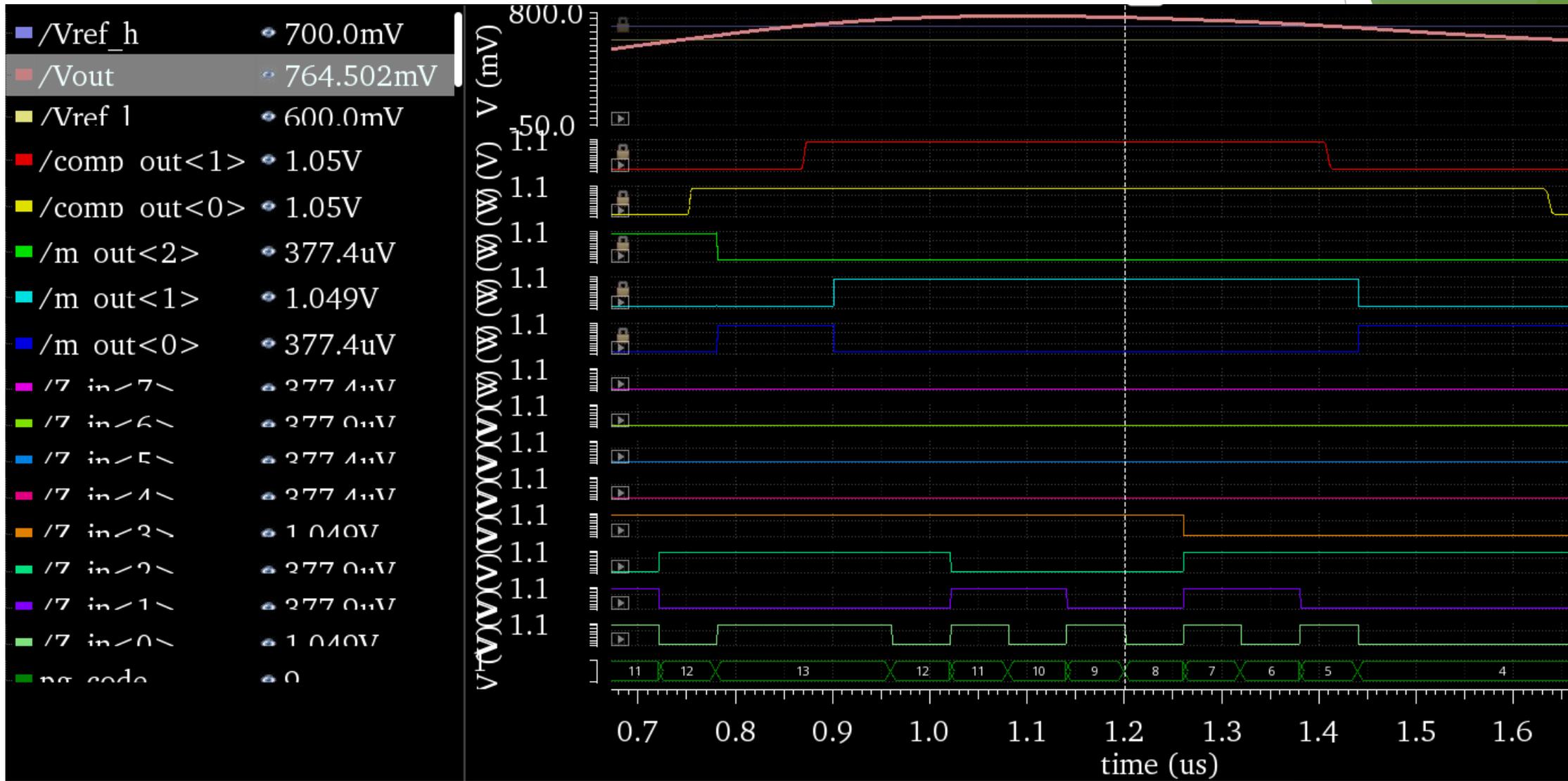


Comp\_out=00, m\_out=100 (Up), pg code is counting up from 7 to 8 to higher # and therefore Vout is increasing

# Continued...

00=0	Up=100=4	Count up
11=3	Down=010=2	Count down
01=1	Hold=001=1	Steady state
10=2	Hold=001=1	Steady state

2. Comparator, decision maker, decision executer output waveform when Vout is decreasing at 1.2us:

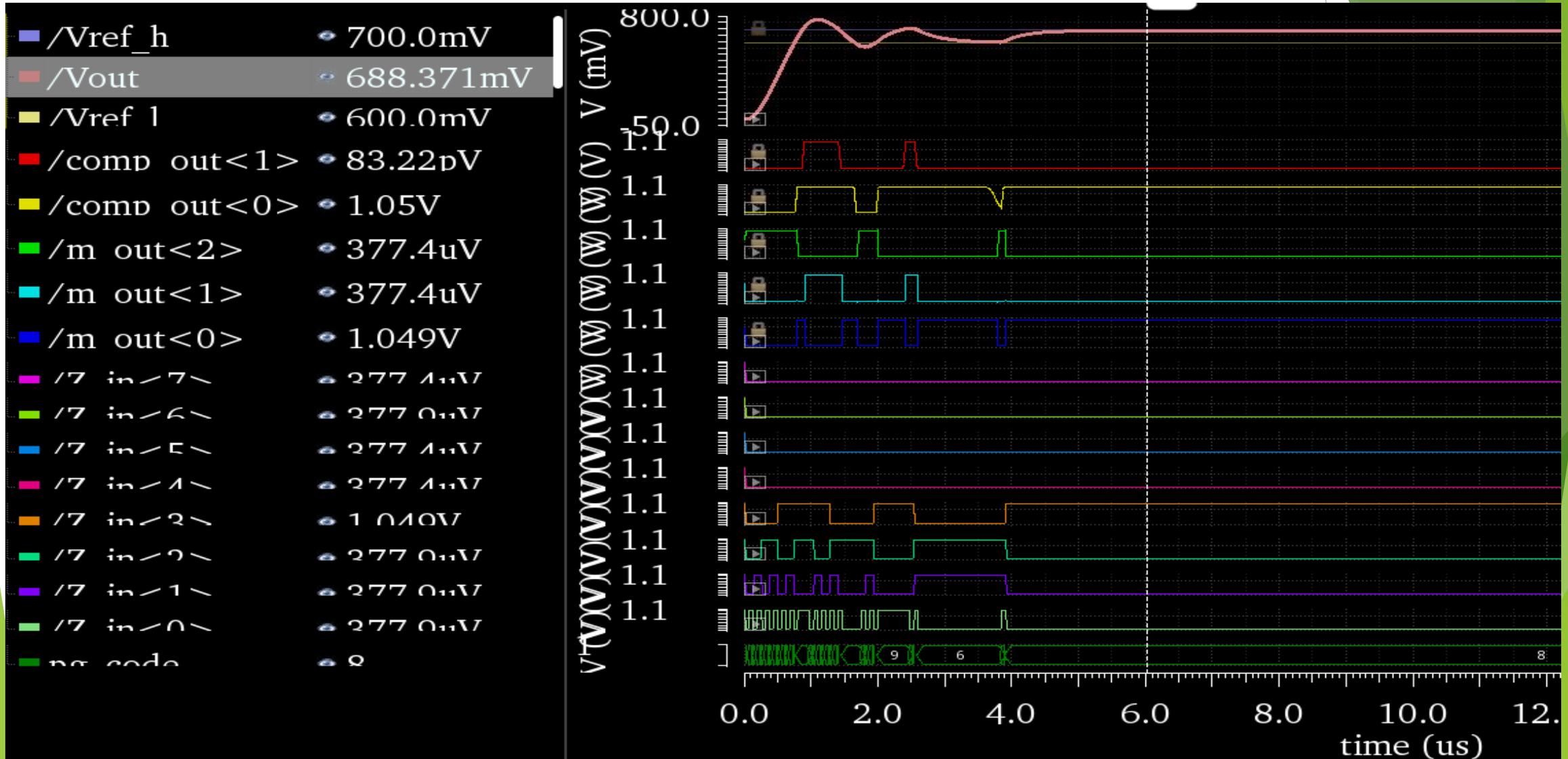


Comp\_out=11, m\_out=010 (Down), pg code is counting down from 9 to 8 to lower # and therefore Vout is decreasing

# Continued...

00=0	Op=100=4	Count up
11=3	Down=010=2	Count down
01=1	Hold=001=1	Steady state
10=2	Hold=001=1	Steady state

3. Comparator, decision maker, decision executor output waveform when Vout is steady at 6us:



Comp\_out=01, m\_out=001 (Hold), pg code is at steady state at 8 and therefore Vout is constant

# Discussion

## 1. Current Efficiency:

- Using Invx1\_rvt standard cells, clock frequency=111MHz, C\_Load=0.01fF, supply voltage=1.05V power consumption of the digital controller was= 90uW after APR
- The current leakage =power consumed by controller/Vin= 90uW/1.05V= 85.7uA. Therefore current efficiency= $I_{Load}/(I_{Load}+I_{Leak})=0.35\text{mA}/(0.35\text{mA}+.0857\text{mA})=0.80 \rightarrow 80\%$  which is within proposed metrics

## 2. Regulation Range:

In this design I was able to achieve voltage range=80mV between  $V_{min}=0V$  and  $V_{max}=V_{in}$ . This turned out to be even better than expected value (100mV)

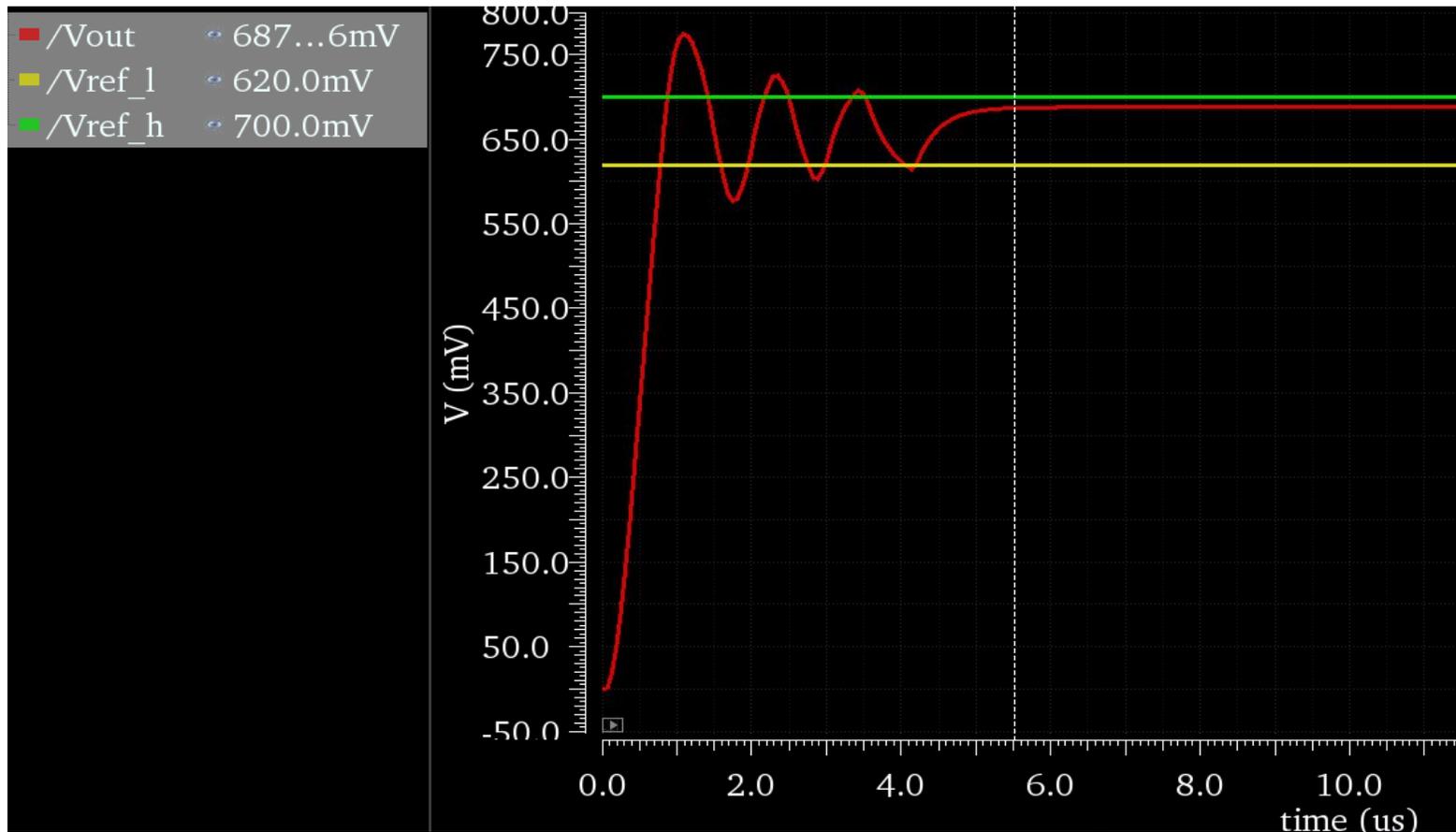
## 3. Clock Frequency:

For the full closed loop LDO, clk period was=6ns $\rightarrow$ clk freq=0.17GHz which meets the proposed metrics

# Discussion Continued...

## 4. Vout Stability:

With the closed loop, the voltage profile looks like the figure below, where Vout is stable/constant between Vref\_l=620mV and Vref\_h=700mV.



# Challenges

1. **Vout was increasing above Vref\_l and Vref\_h even though Z\_in<7:0> was steady:**
  - The reason was the current of Vout was too low compared to the pmos gates. So the current of a single pmos at Vds=700mV was measured and multiplied by 128 (because the biggest pmos size is 128x) which was equal to  $\sim 30\mu\text{A} \cdot 128 = 3840\mu\text{A} = 3.8\text{mA}$ . That means  $I_{\text{Load}} < 3.84\text{mA} \rightarrow R_L > 0.3\text{K}\Omega$ . First  $R_L = 1\text{K}\Omega$  was chosen but  $R_L = 3\text{K}\Omega$  gave better Vout curve. The lower the  $I_{\text{Load}}$  the easier it is for the pmos gates to match the current with it.
  - Still Vout was too high, so clk frequency was lowered by 3x and step size was decreased which made Vout to be in between Vref\_l and Vref\_h.
2. **Vout was too rough and limit cycling (Vout is limited by the resolution of LSB) occurred:**
  - CL was increased by 2x (200pf) which made Vout smoother. Voltage range (between Vref\_l and Vref\_h) could have increased also to fix this issue.

Thank you!

Questions???